Search Notes

Application/Control No.	

Applicant(s)/Patent under Reexamination
DENES, ALAIN

10/009,024 Examiner

Art Unit

John A. Tweel, Jr.

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SEARCHED				
Class	Subclass	Date	Examiner	
340	539.1	10/13/2005	JAT	
	538.11	10/13/2005	JAT	
	538.15	10/13/2005	JAT	
	310.11	10/13/2005	JAT	
	310.16	10/13/2005	JAT	
	332	10/13/2005	JAT	
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INTERFERENCE SEARCHED				
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